



Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V		-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V				-1	<u>,</u>
			TJ=55°C			-5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} I _D =-250μA		-1	-1.8	-3	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V		-30			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =6A			40	50	mΩ
			T _J =125°C		55	70	
		V _{GS} =-4.5V, I _D =-4A			65	85	mΩ
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-6A		6	9.5		S
V _{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-0.78	-1	V
ls	Maximum Body-Diode Continuous Current					-4.2	Α
DYNAMIC	PARAMETERS				•		
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz			700	840	pF
C _{oss}	Output Capacitance				112		pF
C _{rss}	Reverse Transfer Capacitance				78		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			10	15	Ω
SWITCHI	NG PARAMETERS				•		
Q _g (10V)	Total Gate Charge (10V)	V _{GS} =-10V, V _{DS} =-15V, I _D =-6A			14.7	18	nC
Q _g (4.5V)	Total Gate Charge (4.5V)				7.6		nC
Q _{gs}	Gate Source Charge				2		nC
Q _{gd}	Gate Drain Charge				3.8		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =-10V, V _{DS} =-15V, R _L =2.5Ω, R _{GEN} =3Ω			8.6		ns
t _r	Turn-On Rise Time				5		ns
t _{D(off)}	Turn-Off DelayTime				28.2		ns
t _f	Turn-Off Fall Time				13.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-6A, dI/dt=100A/μs			24	30	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-6A, dl/dt=100A/μs			14.7		nC

Electrical Characteristics (T_J=25°C unless otherwise noted)

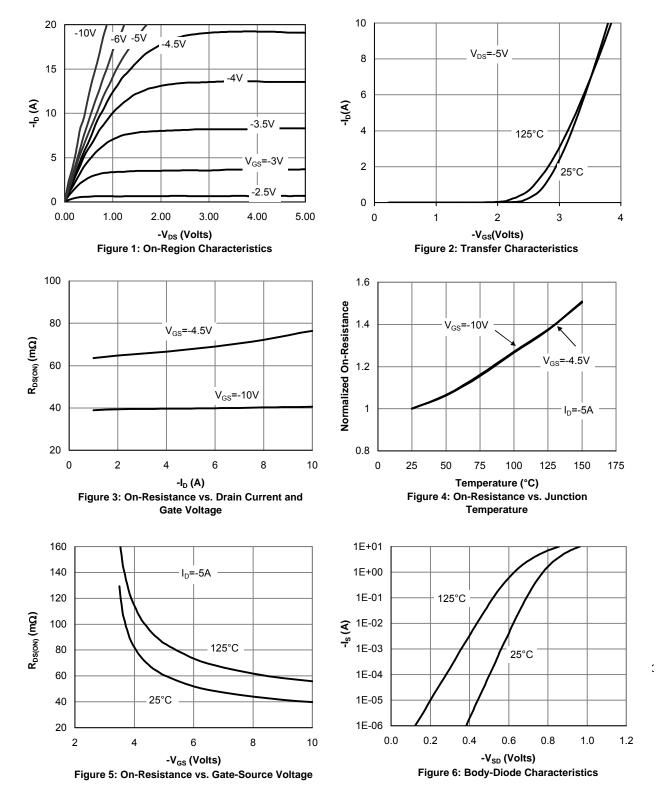
A: The value of $R_{\theta,JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The value in any a given application depends on the user's specific board design. The current rating is based on the ≤ 10 s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 0JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80µs pulses, duty cycle 0.5% max.

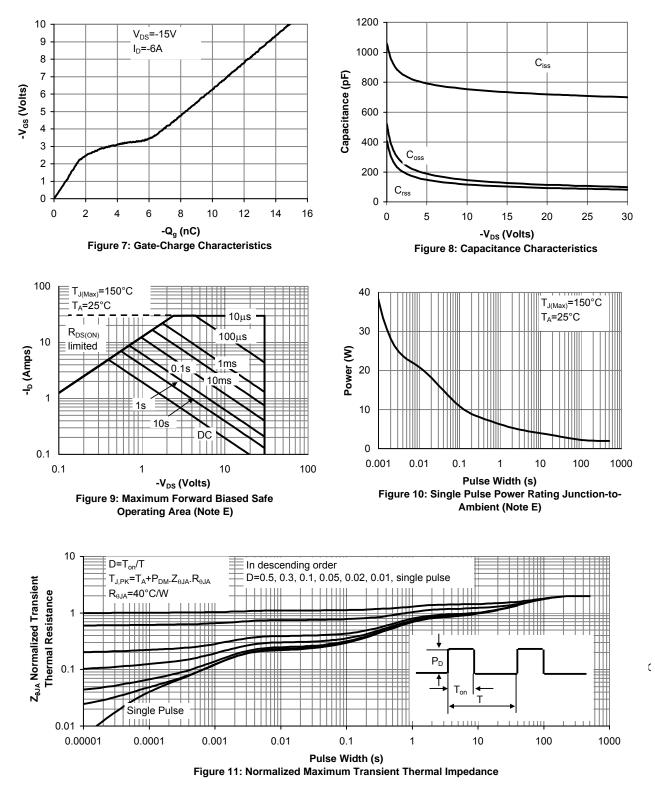
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25$ °C. The SOA curve provides a single pulse rating.

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